Power MOSFET

30 V, 76 A, Single N-Channel, DPAK/IPAK

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- AEC-Q101 Qualified and PPAP Capable NVD4806N
- These Devices are Pb-Free and are RoHS Compliant

Applications

- CPU Power Delivery
- DC-DC Converters
- Low Side Switching

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V_{DSS}	30	V
Gate-to-Source Voltag	е		V _{GS}	±20	V
Continuous Drain		T _A = 25°C	I _D	15.6	Α
Current (R _{θJA}) (Note 1)		T _A = 85°C		12	
Power Dissipation $(R_{\theta JA})$ (Note 1)		T _A = 25°C	P _D	2.65	W
Continuous Drain		T _A = 25°C	I _D	11.3	Α
Current ($R_{\theta JA}$) (Note 2)	Steady	T _A = 85°C		8.8	
Power Dissipation $(R_{\theta JA})$ (Note 2)	State	T _A = 25°C	P _D	1.4	W
Continuous Drain		T _C = 25°C	I _D	79	Α
Current (R _{θJC}) (Note 1)		T _C = 85°C		61	
Power Dissipation $(R_{\theta JC})$ (Note 1)		T _C = 25°C	P _D	68	W
Pulsed Drain Current	t _p =10μs	T _A = 25°C	I _{DM}	150	Α
Current Limited by Pack	age	T _A = 25°C	I _{DmaxPkg}	45	Α
Operating Junction and Storage Temperature			T _J , T _{stg}	-55 to 175	°C
Source Current (Body Diode)			IS	50	Α
Drain to Source dV/dt			dV/dt	6.0	V/ns
Single Pulse Drain-to-Source Avalanche Energy (V_{DD} = 24 V, V_{GS} = 10 V, L = 1.0 mH, $I_{L(pk)}$ = 21 A, R_G = 25 Ω)			E _{AS}	220	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

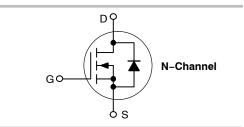
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.



ON Semiconductor®

www.onsemi.com

V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX
30 V	6.0 mΩ @ 10 V	76 A
30 V	9.4 mΩ @ 4.5 V	707



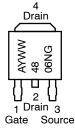


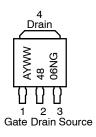
DPAK CASE 369AA (Bent Lead) STYLE 2



IPAK CASE 369AD (Straight Lead) STYLE 2

MARKING DIAGRAMS & PIN ASSIGNMENTS





A = Assembly Location*

Y = Year

WW = Work Week

4806N = Device Code

G = Pb-Free Package

* The Assembly Location Code (A) is front side optional. In cases where the Assembly Location is stamped in the package bottom (molding ejecter pin), the front side assembly code may be blank.

ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 6 of this data sheet.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter		Value	Unit
Junction-to-Case (Drain)	$R_{ heta JC}$	2.2	°C/W
Junction-to-Tab (Drain)	$R_{\theta JC-TAB}$	3.5	
Junction-to-Ambient - Steady State (Note 1)	$R_{ heta JA}$	56.7	
Junction-to-Ambient - Steady State (Note 2)	$R_{ heta JA}$	106.8	

- 1. Surface-mounted on FR4 board using 1 in sq pad size, 1 oz Cu.
- 2. Surface-mounted on FR4 board using the minimum recommended pad size.

ELECTRICAL CHARACTERISTICS (T_{.I} = 25°C unless otherwise noted)

Parameter	Symbol	Test Condi	ition	Min	Тур	Max	Unit
OFF CHARACTERISTICS	•	•	•		•	•	<u> </u>
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V, } I_D = 250 \mu\text{A}$		30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				27		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V,	T _J = 25°C			1.0	μΑ
		V _{DS} = 24 V	T _J = 125°C			10	1
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS}$	= ±20 V			±100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D =$	= 250 μA	1.5		2.5	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				6.0		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 to 11.5 V	I _D = 30 A		4.9	6.0	mΩ
			I _D = 15 A		4.8		
		V _{GS} = 4.5 V	I _D = 30 A		7.9	9.4	1
			I _D = 15 A		7.5		1
Forward Transconductance	gFS	V _{DS} = 15 V, I _D = 15 A			14		S
CHARGES AND CAPACITANCES							
Input Capacitance	C _{iss}				2142		pF
Output Capacitance	C _{oss}	$V_{GS} = 0 \text{ V, f} = 1$ $V_{DS} = 12$			480		1
Reverse Transfer Capacitance	C _{rss}	• • • • • • • • • • • • • • • • • • •			251		1
Total Gate Charge	Q _{G(TOT)}				15	23	nC
Threshold Gate Charge	Q _{G(TH)}	$V_{GS} = 4.5 \text{ V}, V_{D}$	_S = 15 V,		3.0		1
Gate-to-Source Charge	Q_{GS}	I _D = 30 <i>i</i>	A		7.0		
Gate-to-Drain Charge	Q_{GD}				7.0		
Total Gate Charge	Q _{G(TOT)}	$V_{GS} = 11.5 \text{ V}, V_{DS} = 15 \text{ V},$ $I_{D} = 30 \text{ A}$			37		nC
SWITCHING CHARACTERISTICS (Note	e 4)						
Turn-On Delay Time	t _{d(on)}				13.9		ns
Rise Time	t _r	V_{GS} = 4.5 V, V_{DS} = 15 V, I_{D} = 15 A, R_{G} = 3.0 Ω			29.7		1
Turn-Off Delay Time	t _{d(off)}				18.3		1
Fall Time	t _f				7.8		1

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 3. Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 2%.

- 4. Switching characteristics are independent of operating junction temperatures.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted) (continued)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
SWITCHING CHARACTERISTICS	(Note 4)				•		
Turn-On Delay Time	t _{d(on)}				8.5		ns
Rise Time	t _r	$V_{GS} = 11.5 V,$	V _{DS} = 15 V,		23.8		
Turn-Off Delay Time	t _{d(off)}	$I_D = 15 A, R$			26		
Fall Time	t _f				4.7		
DRAIN-SOURCE DIODE CHARA	CTERISTICS						
Forward Diode Voltage	V_{SD}	$V_{GS} = 0 \text{ V}, \qquad T_{J} = 25^{\circ}\text{C}$			0.9	1.2	V
		$I_{S} = 30 \text{ A}$ $T_{J} = 125^{\circ}\text{C}$		0.8			
Reverse Recovery Time	t _{RR}	V _{GS} = 0 V, dls/dt= 100 A/μs, I _S = 30 A			26		ns
Charge Time	ta				13		
Discharge Time	tb				13		
Reverse Recovery Time	Q _{RR}				16		nC
PACKAGE PARASITIC VALUES					•		
Source Inductance	L _S				2.49		nΗ
Drain Inductance, DPAK	L _D	T _A = 25°C			0.0164		
Drain Inductance, IPAK	L _D				1.88		
Gate Inductance	L _G				3.46		
Gate Resistance	R _G				1.0		Ω

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

3. Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.

4. Switching characteristics are independent of operating junction temperatures.

TYPICAL PERFORMANCE CURVES

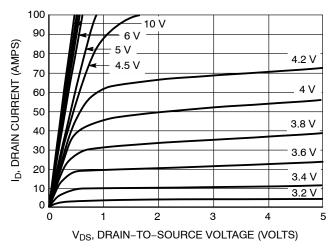


Figure 1. On-Region Characteristics

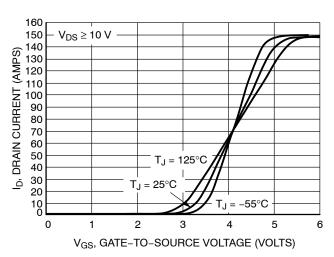


Figure 2. Transfer Characteristics

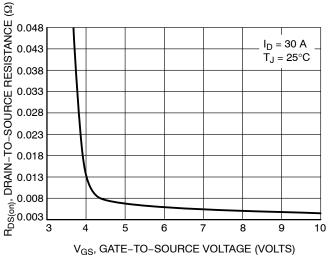


Figure 3. On-Resistance vs. Gate-to-Source Voltage

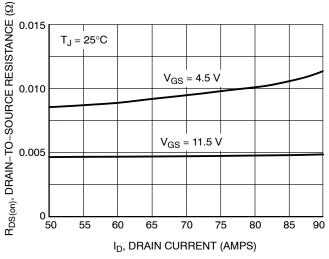


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

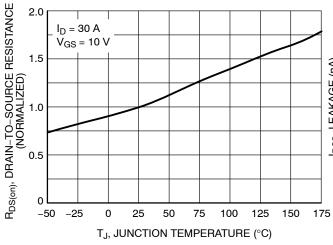


Figure 5. On–Resistance Variation with Temperature

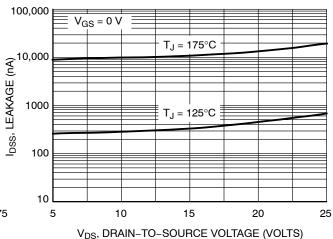
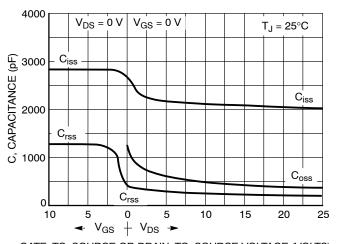


Figure 6. Drain-to-Source Leakage Current vs. Drain Voltage

TYPICAL PERFORMANCE CURVES



GATE-TO-SOURCE OR DRAIN-TO-SOURCE VOLTAGE (VOLTS)

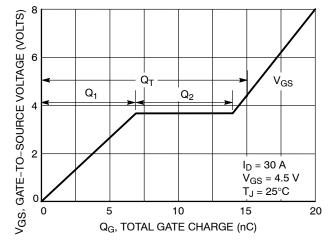


Figure 8. Gate-To-Source and Drain-To-Source Voltage vs. Total Charge



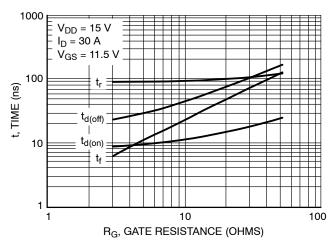


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

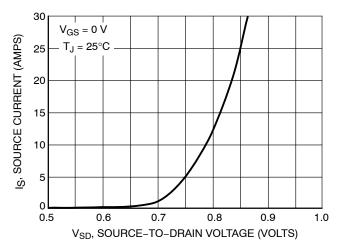


Figure 10. Diode Forward Voltage vs. Current

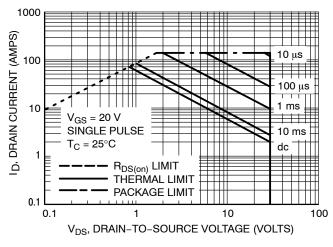


Figure 11. Maximum Rated Forward Biased Safe Operating Area

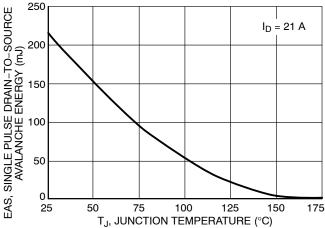


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

TYPICAL PERFORMANCE CURVES

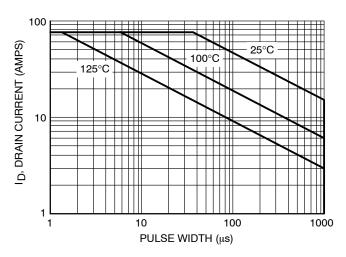


Figure 13. Avalanche Characteristics

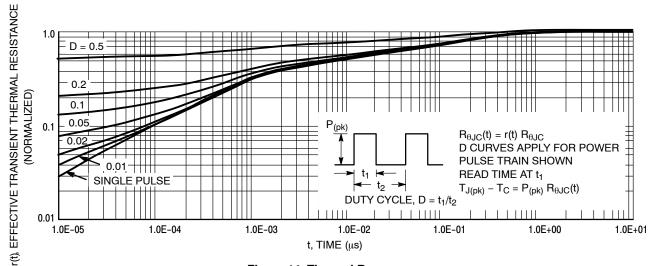


Figure 14. Thermal Response

ORDERING INFORMATION

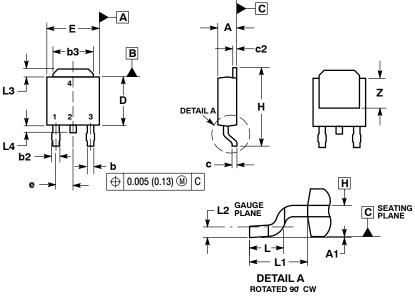
Order Number	Package	Shipping [†]
NTD4806NT4G	DPAK (Pb-Free)	2500 / Tape & Reel
NTD4806N-35G	IPAK Trimmed Lead (3.5 ± 0.15 mm) (Pb-Free)	75 Units / Rail
NVD4806NT4G	DPAK (Pb-Free)	2500 / Tape & Reel
NVD4806NT4G-VF01	DPAK (Pb-Free)	2500 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS

DPAK (SINGLE GUAGE)

CASE 369AA **ISSUE B**



- NOTES:
 1. DIMENSIONING AND TOLERANCING PER ASME
- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
 2. CONTROLLING DIMENSION: INCHES.
 3. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS b3, L3 and Z.
 4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE.
 5. DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
 6. DATUMS A AND B ARE DETERMINED AT DATUM PLANE H.
- PLANE H.

	INC	HES	MILLIM	ETERS
DIM	MIN	MAX	MIN	MAX
Α	0.086	0.094	2.18	2.38
A1	0.000	0.005	0.00	0.13
b	0.025	0.035	0.63	0.89
b2	0.030	0.045	0.76	1.14
b3	0.180	0.215	4.57	5.46
С	0.018	0.024	0.46	0.61
c2	0.018	0.024	0.46	0.61
D	0.235	0.245	5.97	6.22
E	0.250	0.265	6.35	6.73
е	0.090	BSC	2.29 BSC	
н	0.370	0.410	9.40	10.41
L	0.055	0.070	1.40	1.78
L1	0.108 REF		2.74 REF	
L2	0.020 BSC		0.51	BSC
L3	0.035	0.050	0.89	1.27
L4		0.040		1.01
Z	0.155		3.93	

SOLDERING FOOTPRINT*

6.20 3.00 0.244 0.118 2.58 0.102 5.80 1.60 6.17 0.228 0.063 0.243

 $\left(\frac{\text{mm}}{\text{inches}}\right)$ SCALE 3:1

STYLE 2:

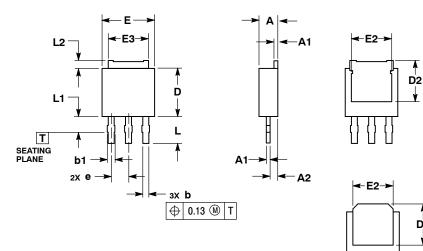
PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

PACKAGE DIMENSIONS

3.5 MM IPAK, STRAIGHT LEAD

CASE 369AD **ISSUE B**



- 1.. DIMENSIONING AND TOLERANCING PER
- ASME Y14.5M, 1994 CONTROLLING DIMENSION: MILLIMETERS
- DIMENSION b APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.15 AND 0.30mm FROM TERMINAL TIP.
- DIMENSIONS D AND E DO NOT INCLUDE MOLD GATE OR MOLD FLASH.

	MILLIMETERS			
DIM	MIN	MAX		
Α	2.19	2.38		
A1	0.46	0.60		
A2	0.87	1.10		
b	0.69	0.89		
b1	0.77	1.10		
D	5.97	6.22		
D2	4.80			
E	6.35	6.73		
E2	4.57	5.45		
E3	4.45	5.46		
е	2.28 BSC			
L	3.40	3.60		
L1		2.10		
L2	0.89	1.27		

STYLE 2:

D₂

OPTIONAL

CONSTRUCTION

PIN 1. GATE

- 2. DRAIN
- SOURCE
- DRAIN

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